Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/658,552	CHOI ET AL.	
Examiner	Art Unit	
Yicun Wu	2165	

	SEARCHED				
Class	Subclass	Date	Examiner		
707	1-10, 100- 104.1	6/7/2006	ΥW		
348	582	6/7/2006	ΥW		
382	164,165	6/7/2006	YW		
382	190,195	6/7/2006	YW		
382	257-260	6/7/2006	ΥW		
382	279,305	6/7/2006	YW		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
inventor search (double patenting) uspto uspgpub epo jpo ibmtech derwent	6/7/2006	YW	
acm ieee citeseer internet Search stratagy attached	6/7/2006	YW	
consulted Apu Mofiz	6/7/2006	YW	